

High Capacitance capacitors

X7R X7S X6S X5R Series



SRT
MICROCÉRAMIQUE
MLCC CAPACITORS

APPLICATIONS

- Digital circuit coupling/decoupling
- High frequency & high-density type power suppliers
- For bypassing
- Ideal for smoothing circuits
- Suitable for DC-DC converter, personal computer and peripherals, telecommunication and general electronic equipment



RoHS compliant



FEATURES

- Realize high capacitance in small sizes
- Basis Metal Electrode
- RoHS and HALOGEN compliant
- Manufactured in Taiwan
- Surface mount suited for wave and reflow soldering
- High reliability and no polarity
- Excellent in high frequency characteristics
- Various termination available
- AEC-Q200 range can be proposed in High Reliability

ELECTRICAL PARAMETERS

ELECTRICAL CHARACTERISTICS :
at + 25°C unless otherwise specified

OPERATING TEMPERATURE :

X7R : - 55°C, + 125°C
X7S : - 55°C, + 125°C
X6S : - 55°C, + 105°C
X5R : - 55°C, + 85°C

TEMPERATURE COEFFICIENT :

X7R : ±15% with 0Vdc applied
X7S : ±22% with 0Vdc applied
X6S : ±22% with 0Vdc applied
X5R : ±15% with 0Vdc applied

DISSIPATION FACTOR :

cf Table

INSULATION RESISTANCE (IR) :

25°C/Un 10⁴ MOhm or 500 Ohm-Farad whichever is less
Except ° table 25°C/Un 10⁴ MOhm or 100 Ohm-Farad whichever is less
Except ° table 50 Ohm-Farad

DIELECTRIC STRENGTH TEST :

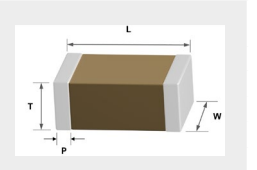
2.5Un for 5s with 50mA max charging current

QUICK REFERENCE DATA (MAX)

	0201			0402				0603				0805				1206				1210				
	X7S	X6S	X5R	X7R	X7S	X6S	X5R	X7R	X7S	X6S	X5R	X7R	X7S	X6S	X5R	X7R	X7S	X6S	X5R	X7R	X7S	X6S	X5R	
2.5V																								330µF
4V	1.0µF	2.2µF		2.2µF		22µF	22µF	4.7µF		47µF	47µF	22µF		100µF	100µF	22µF		100µF	220µF	47µF		220µF	330µF	
6.3V	1.0µF		4.7µF	2.2µF		10µF	22µF	4.7µF	10µF	22µF	47µF	22µF		47µF	100µF	22µF	47µF	47µF	220µF	47µF	100µF	100µF	220µF	
10V		1.0µF		2.2µF	2.2µF	4.7µF	10µF	2.2µF		10µF	22µF	10µF	22µF	22µF	47µF	22µF		22µF	100µF	47µF	47µF	47µF	100µF	
16V			2.2µF			2.2µF	4.7µF	2.2µF	4.7µF	10µF	10µF	10µF		22µF	22µF	22µF	22µF	22µF	47µF	22µF		47µF	100µF	
25V					1.0µF	2.2µF	1.0µF	2.2µF	4.7µF	10µF	4.7µF	10µF	10µF	10µF	10µF	10µF		10µF	22µF	22µF		22µF	47µF	
35V						2.2µF	1.0µF		2.2µF	4.7µF	4.7µF	10µF	4.7µF		10µF	22µF	10µF		10µF	10µF	10µF		10µF	
50V							1.0µF		2.2µF	4.7µF	4.7µF			4.7µF	10µF	10µF		4.7µF	4.7µF	10µF		4.7µF	10µF	
100V													1.0µF		4.7µF					10µF				

DIMENSIONS IN MILLIMETERS

	0201	0402	0603	0805	1206	1210
Length (L)	0.60 ± 0.05 (0.09 C>1.0µF)	1.00 ± 0.20	1.60 ± 0.15	2.00 ± 0.20	3.20 ± 0.20	3.20 ± 0.30
Width (W)	0.30 ± 0.05 (0.09 C>1.0µF)	1.00 ± 0.20	0.80 ± 0.202	1.25 ± 0.20	1.60 ± 0.20	2.50 ± 0.30
Thickness max (T)	0.33	0.70	0.95	1.45	1.90	2.80
Termination (P)	Min	0.10	0.15	0.30	0.40	0.40
	Max	0.20	0.30	0.55	0.70	1.10



ORDERING INFORMATION

0805	T	475	M	X	X	B	BM	
SIZE	DIELECTRIC	CAPACITANCE	TOLERANCE	VOLTAGE	TERMINATION	PACKAGING	BME	SPECIAL PARAMETERS
0201 0402 0603 0805 1206 1210	Y = X7R T = X7S S = X5R R = X6S	Expressed in picofarads (pF). The first two digits are significant, the third digit gives the number of noughts. Example : 102 = 1 000pF	K = ±10 % (X7S, X5R, X6S) M = ±20 % (X7S, X5R, X6S)	V = 2.5V Y = 4V R = 6.3V Q = 10V J = 16V X = 25V Z = 35V A = 50V B = 100V	X = Nickel Tin W = Nickel Gold Flash G = Nickel Gold Thick H = Dipped SnPb S = Dipped SAC I = Electrolytic SnPb Q = Solderable Silver	B = Taping Reel V = Bulk	BM = BME	- Dxx = Reliability spec D20 = AEC-Q200

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High Capacitance capacitors

X7R X7S X6S X5R Series



DF TABLE : X7R/X7S/X6S/X5R

Rated	D.F.≤	Exception of D.F.≤	
100V	≤2.5%		
50V	≤2.5%	≤3.5%	1206<2.2μF, 1210≥2.2μF, 1812≥4.7μF
		≤5%	0201, 1210≥4.7μF
		≤10%	0402, 0603, 0805, 1206≥2.2μF, 1210≥10μF
35V	≤10%		
25V	≤3.5%	≤5%	0805, 1210≥10μF
		≤10%	0201, 0603, 0805≥2.2μF, 1206≥2.2μF, 1210≥22μF
		≤12.5%	0402
16V	≤3.5%	≤5%	0805<2.2μF, 1206≥2.2μF, 1210≥4.7μF
		≤10%	0201, 0402, 0603, 0805≥2.2μF, 1206≥4.7μF, 1210≥22μF
		≤15%	0603<10μF, 0805≥2.2μF, 1206≥2.2μF, 1210≥22μF
10V	≤5%	≤10%	0201, 0402, 0603≥10μF
		≤15%	
		≤20%	0201, 0402<2.2μF, 0603≥10μF, 0805≥4.7μF, 1206≥4.7μF, 1210≥100μF
6.3V	≤10%		
4V	≤15%		

THICKNESS CODE :

Code	Thickness (mm)
C	0.30±0.04
E	0.50±0.05
G	0.50±0.20
J	0.80±0.07
K	0.80±0.10
M	0.95±0.10
O	1.15±0.15
P	1.25±0.10
Q	1.25±0.20
T	1.60±0.20
U	1.70±0.20
W	2.00±0.20
X	2.25±0.25
Y	2.50±0.30

X7R

CODE	SIZE	CAP	0402		0603					0805					1206					1210								
			4V	10V	6.3V	10V	16V	25V	35V	50V	6.3V	10V	16V	25V	50V	6.3V	10V	16V	25V	35V	50V	100V	6.3V	10V	16V	25V	50V	63V
105	1.0 μF	J	J	J	J	J	J	J	J	P	P	P	P	O	O	O	O	T	T	T	T	P	P	P	Y	W	Y	Y
155	1.5 μF									O	O	O	O	O	O	O	O	T	T	T	T	T	T	T	Y	Y	Y	Y
225	2.2 μF	J	J	J	J	J				O	O	O	O	O	O	O	O	T	T	T	T	T	T	Y	Y	Y	Y	Y
335	3.3 μF									O	O	O	O	O	T	T	T	T	T	T	T	T	T	Y	Y	Y	Y	Y
475	4.7 μF			J						O	O	O	O	O	T	T	T	T	T	T	T	W	W	W	Y	Y	Y	Y
685	6.8 μF														T	T	T	T	T	T		W	W	W	Y	Y	Y	Y
106	10 μF									O	O	O			T	T	T	T	T	T		W	W	W	Y	Y	Y	Y
226	22 μF									O					T	T	T					Y	Y	Y	Y	Y		
476	47 μF																					Y	Y					
107	100 μF																											

Yellow : AECQ-200, White : Industrial

High Capacitance capacitors

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X7S

SIZE	CAP	0402		0603				0805				1206		1210	
		6.3V	10V	6.3V	10V	16V	25V	10V	25V	100V	6.3V	16V	6.3V	10V	
105	1.0 µF														
155	1.5 µF														
225	2.2 µF	G°	G°	K°	K°	K°	K°								
335	3.3 µF														
475	4.7 µF			K°	K°	K°									
685	6.8 µF														
106	10 µF			K°				O°	O°						
226	22 µF							O°				U°			
476	47 µF											U°		Y°	
107	100 µF												Y°		
227	220 µF														

Yellow : AECQ-200, White : Industrial

* : tolerance M only, ° : RC≥10⁴ MOhm or 100 Ω/F whichever is less, °° : RC≥50 Ω/F

X6S

SIZE	CAP	0201		0402				0603					0805					1206					1210														
		4V	10V	4V	6.3V	10V	16V	25V	4V	6.3V	10V	16V	25V	35V	4V	6.3V	10V	16V	25V	35V	50V	4V	6.3V	10V	16V	25V	35V	50V	2.5V	4V	6.3V	10V	16V	25V	50V		
105	1.0 µF																																				
155	1.5 µF																																				
225	2.2 µF																																				
335	3.3 µF																																				
475	4.7 µF																																				
685	6.8 µF																																				
106	10 µF																																				
226	22 µF																																				
476	47 µF																																				
107	100 µF																																				
227	220 µF																																				
330	330 µF																																				

Yellow : AECQ-200, White : Industrial

* : tolerance M only, ° : RC≥10⁴ MOhm or 100 Ω/F whichever is less, °° : RC≥50 Ω/F

X5R

SIZE	CAP	0201			0402					0603					0805					1206					1210													
		6.3V	10V	16V	4V	6.3V	10V	16V	25V	35V	4V	6.3V	10V	16V	25V	35V	50V	6.3V	10V	16V	25V	35V	50V	4V	6.3V	10V	16V	25V	35V	50V	4V	6.3V	10V	16V	25V	50V		
105	1.0 µF	C°	C°	C°	G°	G°	G°	E°	E°	E°																												
155	1.5 µF																																					
225	2.2 µF				C°	T°	T°	E°	G°	G°	G°																											
335	3.3 µF																																					
475	4.7 µF																																					
685	6.8 µF																																					
106	10 µF																																					
226	22 µF																																					
476	47 µF																																					
107	100 µF																																					
227	220 µF																																					
330	330 µF																																					

Yellow : AECQ-200, White : Industrial

* : tolerance M only, ° : RC≥10⁴ MOhm or 100 Ω/F whichever is less, °° : RC≥50 Ω/F

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Different types of dielectrics display very different behaviours when it comes to withstanding power and heat, and don't demonstrate the same capacitance potential. SRT-Microcéramique proposes a wide range of ceramics. You'll find in the page below more information about what type of ceramic is better suited to your needs.

Class I Dielectrics

Class I Dielectrics are the most stable type and are used when the application demands highly stable performance and cannot allow electrical noise or dielectric loss. Variations of voltage and temperature have minimum consequences on this class of dielectrics. Consequently, they are most used for DC blocking, decoupling applications as well as filtering with low capacitance.

Q (Code Q)

- High Q (>2000)
- RF application up to 30 GHz
- High Current

NPO (Code A)

- Most stable type
- Lower capacitance
- Good for avoiding electrical noise

Class 1 N2200 Dielectrics

Class I stability with close to Class II volumetric capacitance

N2T (Code P)

- Ultra stable
- No piezo electric effect
- High current pulse discharge

Class II Dielectrics

Class II Dielectrics display stable performance and possess a better volumetric efficiency than class I. Thus, they are used in bypassing, filtering, coupling and decoupling applications.

X7R (Code Y)

- Good volumetric efficiency
- High capacitance
- Stable

BX/BY (Code X/2C1)

- Improved ESR
- Better voltage coefficient
- MIL specifications

X5R/X7S/X6S/Y5V (Code R/T/S/V)

- Highest capacitance per volume
- Less stable
- Low voltage

Dielectric	Class I			Class II						
	High Q	NPO/COG	N2T	X7R	BX	2C1	X5R	X7S	X6S	Y5V
SRT Code	Q	A	P	Y	X	2C1	R	T	S	V
Type	Ultra Stable			Stable						
Temperature Range	-55°C +125°C (250°C)			-55°C +125°C			-55°C +85°C	-55°C +125°C	-55°C +105°C	-25°C +85°C
T° Coefficient no DC applied	± 30ppm		2200ppm ± 350	± 15%		± 20%	± 15%	± 22%		+30% -80%
T° Coefficient rated DC applied	-		-	-	+15 -25%	+20 -30%	-	-	-	-
Dielectric constant	10-100		450	2000-3000			3000-20000			
Dissipation Factor	0.01% 0.05%	0.05% 0.1%		1% 3.5%			2.5% 15%		5% 20%	
IR 25°C/Un	100 GΩ or 1000 Ω-F whichever is less						10 GΩ or 100 Ω-F whichever is less			
Dielectric strenght ≤200V	2.5 Ur 5 seconds 50mA max									
Dielectric strenght <500V	Ur + 250V 5 seconds 50mA max									
Dielectric strenght <1000V	1.5 Ur 5 seconds 50mA max									
Dielectric strenght ≥1000V	1.2 Ur 5 seconds 50mA max									
Piezo effect	No piezo			piezo effect						
Ageing	None			2% per decade	1% per decade		4% per decade	5% per decade		7% per decade
Tolerance	± 0.25pF ± 0.5pF ± 1% ± 2% ± 5% ± 10%			± 5% ± 10% ± 20%			± 10% ± 20%		-20% +80%	
Termination	X,C,H		X,F,P,C,W,H,I			X,P		X		

All our capacitors are available with a wide range of termination to fit your specific needs :

Tin (Code X)

- Standard termination
- ROHS
- Dipped Silver, Nickel barrier, Sn plated

Polymer (Code P)

- Flexible termination
- Improve bending tolerance
- ROHS
- Available on all components
- Designed for gluing

Silver-Palladium (Code F)

- Excellent contact properties
- Resist to leaching during hand soldering
- Dipped Silver-Palladium
- ROHS

Gold Flash (Code W)

- Glueing
- ROHS
- Max 0.2µm Gold Flash

Gold Thick (Code G)

- Microelectronic applications
- Wire Bonding/glueing
- ROHS
- Min 2.5µm Gold

Non Magnetic (Code C/CP)

- High Tesla Applications
- IRM, particule accelerators
- Dipped Silver, Copper barrier, Sn plated
- ROHS

Solderable Silver (Code Q)

- Medical or space application
- Whiskers free
- High temperature
- ROHS

Dipped SAC 305 (Code S/SP)

- Sn96.5 Ag3 Cu0.5
- Medical, space and oil application
- Whiskers free
- High reliability
- ROHS

Dipped Tin-Lead (Code H/HP)

- Sn62 Pb36 Ag2
- Medical or Oil application
- Whiskers free
- High reliability

Electrolytical Tin-Lead (Code I/IP)

- Minimum Pb 10%
- Medical or space application
- Whiskers free
- High reliability

TERMINATION	CODE	ROHS	NON MAGNETIC	IMPROVED BOARD FLEX	SOLDERING	GLUING	WIRE BONDING
Sn	X	0			0		
Polymer	P	0		0	0		
AgPd	F	0			0	0	
Gold Flash	W	0			0	0	
Gold Thick	G	0			0	0	0
Non Magnetic	C	0	0		0		
Solderable Silver	Q	0			0		
Dipped SnPb	H				0		
Dipped SAC	S	0			0		
Electrolytical SnPb	I				0		
Lead	-	0		0	0		
Non Magn Lead	C	0	0	0	0		
Lead Frame	-	0		0	0		
Non Magn Lead Frame	C	0	0	0	0		

0 = COMPLIANT

STORAGE

To prevent the damage of solderability of terminations, the following storage conditions are recommended :

Indoors under 5 ~ 40°C and 20% ~ 70% RH.

No harmful gases containing sulfuric acid, ammonia, hydrogen sulfide or chlorine.

Packaging should not be opened until the capacitors are required for use. If opened, the pack should be re-sealed as soon as possible. Taped products should be stored out of direct sunlight, which might promote deterioration in tape or adhesion performance. The product is recommended to be used within 24 months after shipment. Extended shelf life over this period require a solderability check before use.

HANDLING

Chip capacitors are dense, hard, brittle, and abrasive materials. They are liable to suffer mechanical damage, in the form of cracks or chips. Chip Capacitors should be handled with care to avoid contamination or damage. To use vacuum or plastic tweezers to pick up or plastic tweezers is recommended for manual placement. Tape and reeled packages are suitable for automatic pick and placement machine.

PREHEAT

In order to minimize the risk of thermal shock during soldering, a carefully controlled preheat is required.

The rate of preheat should not exceed 3°C per second.

SOLDERING FLUX

Use mildly activated rosin RA and RMA fluxes, but do not use activated flux. The amount of solder in each solder joint should be controlled to prevent the damage of chip capacitors caused by the stress between solder, chips, and substrate.

SOLDERING TYPE

Lead containing solders, such as Sn60, Sn62 or Sn63 and lead free solders, such as SnAgCu, can all be used with our MLCCs.

In case of non-magnetic termination code C, use lead containing or lead (Pb)-free SAC305 solders.

SOLDERING HEIGHT

The solder climbing minimum height is suggesting to 25% of chip thickness or 500um whichever is less.

(Reference from IPC-610E)

COOLING

After soldering, cool the chips and the substrate gradually to room temperature. Natural cooling in air is recommended to minimize stress in the solder joint.

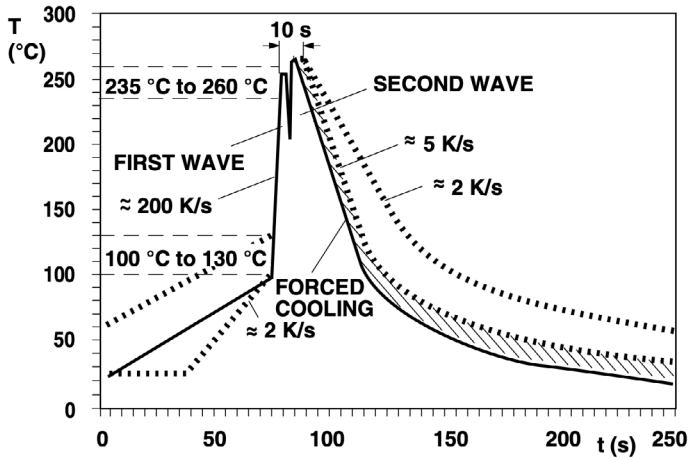
CLEANING

All flux residues must be removed by using suitable electronic-grade vapor-cleaning solvents to eliminate contamination that could cause electrolytic surface corrosion. Good results can be obtained by using ultrasonic cleaning of the solvent. The choice of the proper system is depends upon many factors such as component mix, flux, and solder paste and assembly method. The ability of the cleaning system to remove flux residues and contamination from under the chips is very important.

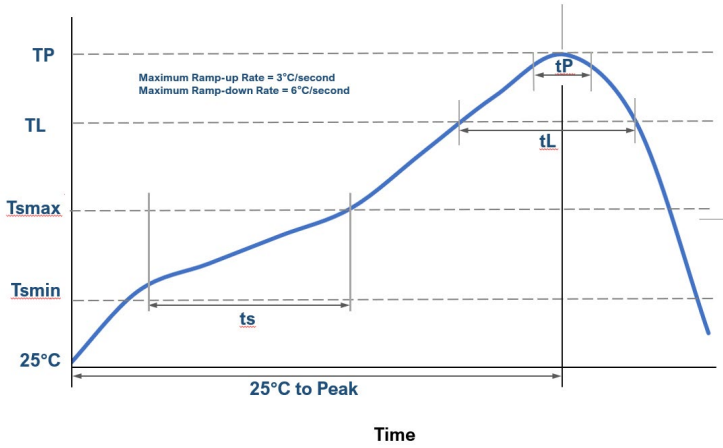
SOLDERING CONDITIONS

SIZE	THICKNESS	WAVE	REFLOW
0201	All	0	0
0402	All	0	0
0505	All	0	0
0603	All	0	0
0805	< 1.25mm	0	0
0805	≥ 1.25mm		0
1111	< 1.25mm	0	0
1111	≥ 1.25mm		0
1206	< 1.25mm	0	0
1206	≥ 1.25mm		0
1210	< 1.25mm	0	0
1210	≥ 1.25mm		0
larger than 1210	All		0
High compact	All		0

WAVE SOLDERING PROFILE

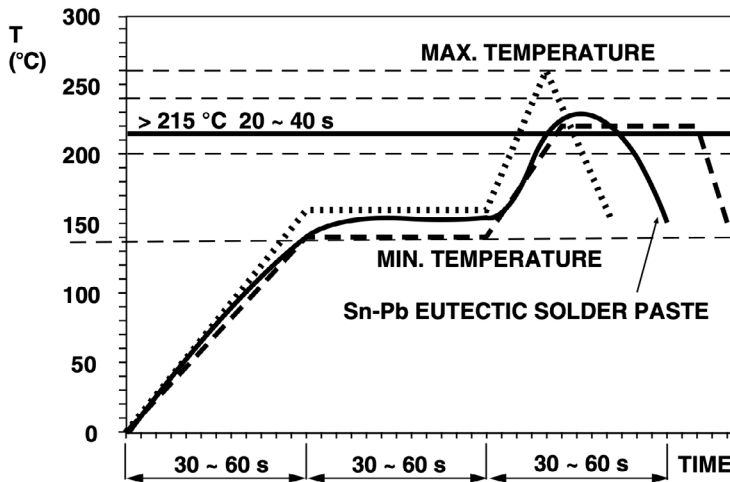


LEADFREE REFLOW SOLDERING PROFILE

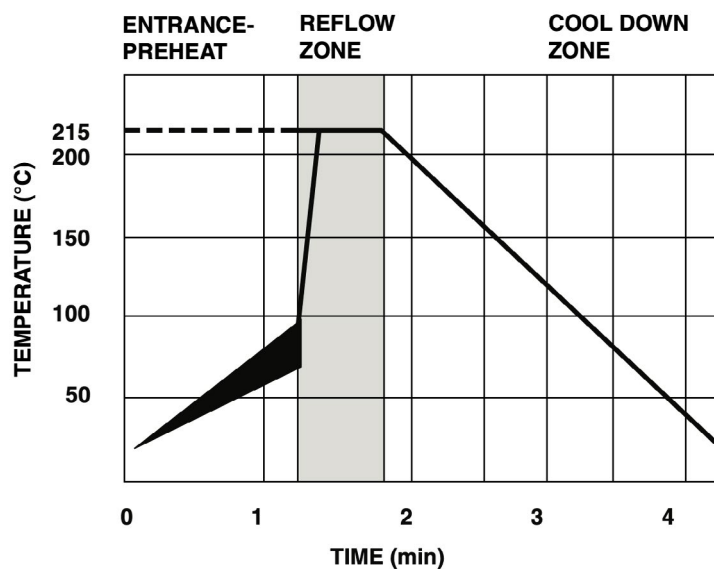


PROFILE FEATURE	LEAD FREE (SAC 305)
Tsmin	150°C
Tsmax	190°C
Time from Tsmin to Tsmax	60 - 120 seconds
Ramp-up Rate	3°C/second max
Liquidous Temperature	217°C
Time above Liquidous	60 - 120 seconds
Peak Temperature	250°C
Time within 5°C of maximum	10 seconds max
Peak Temperature	250°C
Ramp-down Rate	6°C/second max
Time 25°C to Peak	8min max

SNPB REFLOW SOLDERING PROFILE



VAPOUR PHASE REFLOW PROFILE



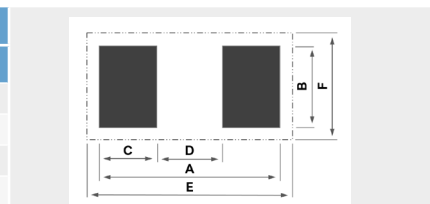
HAND SOLDERING

Hand soldering is not recommended as the thermal shock may cause a crack, hot air pencil use is advised, however if used the following recommendations should be taken :

- Soldering iron tip diameter ≤ 3.0 mm and wattage max. 20W.
- The Capacitors shall be pre-heated to 150°C and that the temperature gradient between the devices and the tip of the soldering iron.
- Tip temperature ≤ 280 °C and should't be applied for more than 5 seconds.
- The required amount of solder shall be melted on the soldering tip.
- The tip of iron should not contact the ceramic body directly.
- The Capacitors shall be cooled gradually at room temperature after soldering.
- Forced air cooling is not allowed.

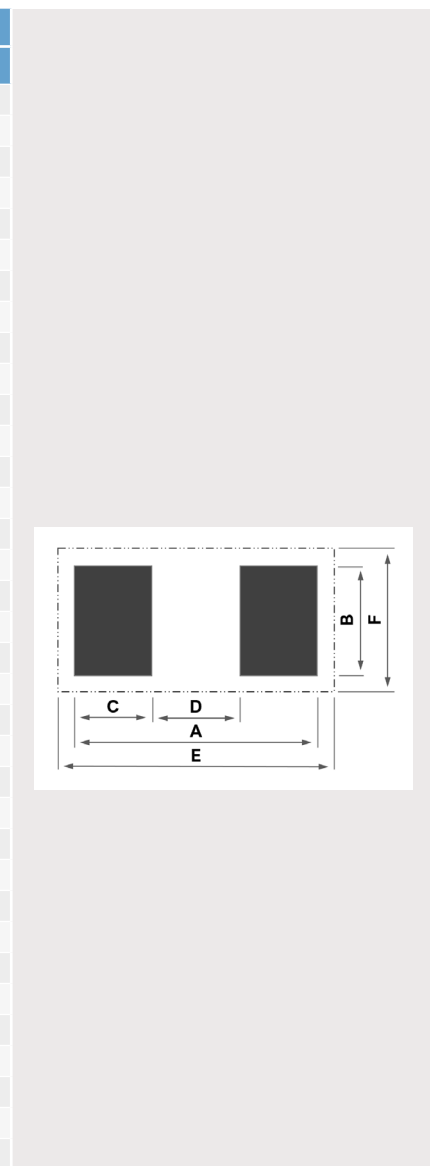
TYPICAL SMD FOOTPRINT WAVE SOLDERING

SIZE	FOOTPRINT DIMENSIONS IN MM					
	A	B	C	D	E	F
0603	2.40	0.80	0.70	1.00	3.10	1.40
0805	3.20	1.30	0.90	1.40	4.10	1.85
1206	4.80	1.70	1.25	2.30	5.90	2.25
1210	4.80	2.60	1.25	2.30	5.90	3.15



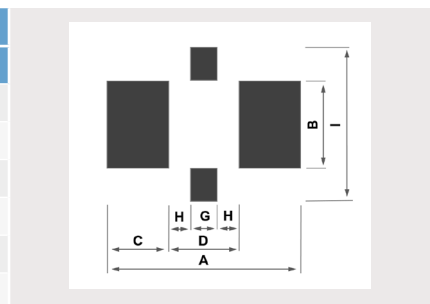
TYPICAL SMD FOOTPRINT REFLOW SOLDERING

SIZE	FOOTPRINT DIMENSIONS IN mm					
	A	B	C	D	E	F
0201	0.65	0.30	0.21	0.23	0.90	0.60
0204	1.00	1.00	0.30	0.40	1.25	1.45
0402	1.50	0.50	0.40	0.70	1.75	0.95
0306	1.30	1.60	0.40	0.50	1.55	2.05
0404	1.50	1.00	0.40	0.70	1.75	1.45
0504	1.90	1.00	0.40	1.10	2.15	1.45
0505	1.90	1.30	0.50	0.80	2.15	1.75
0508	1.90	2.00	0.50	0.90	2.15	2.55
0603	2.30	0.80	0.60	1.10	2.55	1.35
0612	2.30	3.20	0.60	1.10	2.55	3.75
0805	2.90	1.25	0.90	1.10	3.15	1.80
1206	4.10	1.60	0.90	2.30	4.35	2.25
1210	4.10	2.50	1.00	2.10	4.35	3.15
1808	5.50	2.10	1.20	3.10	5.75	2.75
1812	5.50	3.30	1.20	3.10	5.75	3.95
1825	5.50	6.55	1.20	3.10	5.75	7.20
2211	6.80	3.00	1.40	4.00	7.05	3.65
2220	6.80	5.40	1.40	4.00	7.05	6.05
2225	6.80	6.70	1.65	3.50	7.05	7.50
2525	7.70	6.75	1.65	4.40	7.95	7.55
2825	8.40	6.70	1.65	5.10	8.65	7.50
3033	9.00	8.80	1.95	5.10	9.25	9.60
3640	10.55	10.70	2.35	5.85	10.80	11.50
4017	11.60	4.60	2.35	6.90	11.85	5.25
4020	11.60	5.40	2.35	6.90	11.85	6.05
4040	11.60	10.70	2.35	6.90	11.85	11.50
40100	11.60	26.20	2.35	6.90	11.85	27.00
5550	15.50	13.20	2.35	10.80	15.75	14.00
6080	16.70	20.80	2.35	12.00	16.95	21.60
6660	18.30	15.70	2.35	13.60	18.55	16.50
8060	21.90	15.70	2.35	17.20	22.15	16.50
80150	21.90	38.90	2.35	17.20	22.15	39.70
HIGH COMPACT 1210	4.15	2.60	1.15	1.85	5.05	3.30
HIGH COMPACT 1812	5.75	3.40	1.35	3.05	6.70	4.20
HIGH COMPACT 2220	6.80	5.50	1.70	3.40	7.70	6.30



TYPICAL FILTER FOOTPRINT REFLOW SOLDERING

SIZE	FOOTPRINT DIMENSIONS IN mm						
	A	B	C	D	G	H	I
0603	2.30	0.80	0.45	1.40	0.60	0.40	1.50
0805	2.90	1.25	0.90	1.80	0.80	0.50	2.00
1206	4.10	1.60	0.90	2.40	1.00	0.70	3.00
1806	5.50	1.60	1.20	3.20	1.00	1.10	3.00
1812	5.50	3.30	1.20	3.90	1.50	1.20	4.80
2220	6.80	5.40	1.40	4.50	1.50	1.50	7.00



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ORDERING INFORMATION

SRMC	-	0603	Y	102	J	A	-	L	040	-	-	-	B	-
SERIE	HT	SIZE	DIELECTRIC	CAPACITANCE	TOLERANCE	VOLTAGE	TERMINAISON	FORM	HEIGHT	LEADS	COATING/MARKING	CUR-RENT	PACKAGING	SPECIAL
-	-	0201	Q = High Q	Expressed in	A = ± 0.05pF/0.1%	V = 2.5V	- = Sn lead/lead frame	-	020	-	-	-	B = Reel	-
FK	H = High	0204	A = NP0	picofarads (pF)	B = ± 0.1pF	Y = 4V	X = Nickel Tin	J	030	-	-	1	V = Bulk	BM = BME
FH	Temp	0402	P = N2T	The first two digits	C = ± 0,25pF	R = 6.3V	F = Palladium-Silver	L	040	2 to 10	I = Conformal-	2	T = Tray	Dxx = Reliability
SREV		0303	X = BX	are significant,	D = ± 0,5pF	Q = 10V	P = Polymer Tin (Flex)	D	050	B	Coating		Package	spec
MCF		0306	Y=X7R	the third digit gives the	E = ± 0.5%	J = 16V	C = Copper Tin (Non	M	060		H = Epoxy		Coating	Exx = Sorting spec
M2F		0404	BY=2C1	number of noughts	F = ± 1%	X = 25V	magnetic)	T = 2	070		Coating		R = Resistor	
MPF		0504	T = X7S	Example : 102 = 1	G = ± 2%	Z = 35V	CP = Copper Polymer Tin	leads	080		M = Marked		W = Waffle	
SRMC		0505	S = X5R	000pF	J = ± 5%	A = 50V	(Non magnetic)	U = 4	090		R = Resistor		Pack	
SRTV		0508	R = X6S		K = ± 10%	U = 63V	W = Nickel Gold Flash	leads	110					
SR		0603	V = Y5V	For special values	M = ± 20%	B = 100V	G = Nickel Gold Thick		120					
SA		0612	U = X8R	R is used as decimal	Z = -20% +80%	N = 150V	HP = Dipped SnPb Polymer		130					
SF		0805		separator		C = 200V	H = Dipped SnPb		140					
H		1206		Example 12R7 = 12.7pF		P = 250V	S = Dipped SAC		160					
		1210		1340R0 = 1340pF		D = 300V	SP = Polymer Dipped SAC		180					
		1808				E = 500V	I = Electrolytic SnPb							
		1812				F = 630V	IP = Polymer Electrolytical							
		1825				G = 1000V	SnPb							
		2211				1K2 = 1200V	Q = Solderable Silver							
		2220				1K4 = 1400V	M = Microstrip							
		2225				O = 1500V	A = Axial Ribbon							
		2325				1K7 = 1700V	R = Radial Ribbon							
		2525				1K8 = 1800V	U = Axial Wire							
		2825				H = 2000V	V = Radial Wire							
		3033				T = 2500V	CM = Microstrip (Non							
		3640				I = 3000V	magnetic)							
		4040				M = 3600V	CA = Axial Ribbon (Non							
		40100				K = 4000V	magnetic)							
		5550				L = 5000V	CR = Radia Ribbon (Non							
		6080				6 = 6000V	magnetic)							
		6660				S = 7200V	CU = Axial Wire (Non							
		7274				8 = 8000V	magnetic)							
		7565				10 = 10000V	CV = Radial Wire (Non							
		8060				12 = 12000V	magnetic)							
		80150				15 = 15000V								
		15080												
		40 to 94												

RELIABILITY/SCREENING LEVEL

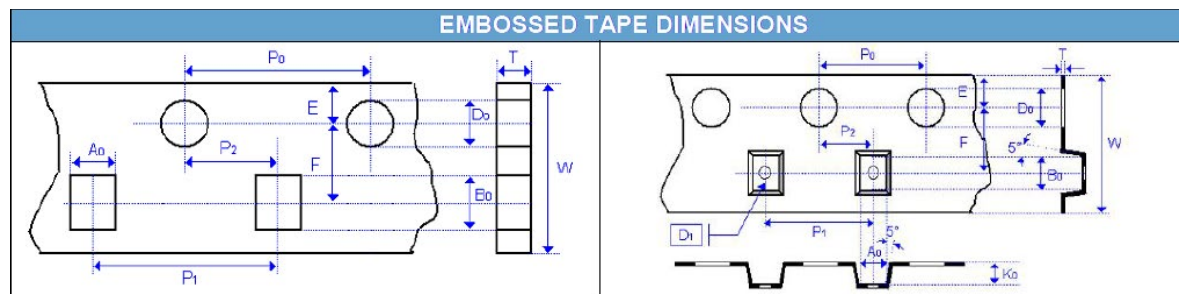
OPTIONAL CODE	TESTING DETAIL
D20	Generic AECQ-200
D55681	DPA & 100% Burn-In Per Group A of MIL-PRF-55681
D123	Group A & B Per MIL-PRF-123
D3009CFM	Screened and LAT according to ECSS-3009 for space application C Level
D3009CEM	Evaluation version for space development according to ECSS-2310 C Level
COTS1	Class 1 COTS+ according to ECSS-Q-ST-60-13C-Rev1
COTS2	Class 2 COTS+ according to ECSS-Q-ST-60-13C-Rev1
COTS3	Class 3 COTS+ according to ECSS-Q-ST-60-13C-Rev1
D03	High Temperature application Burn-In 100% 125° 168H 2Un, 6.5% AQL
D05	Burn-In 100% 125° 168H 2Un, less than 5% default allowed VRT CEI 68-2-14 10 cycles 0V -55°C/+125°C, less than 5% default allowed 20 pieces life test 125°C, 1.5Un, 1 default allowed

SORTING

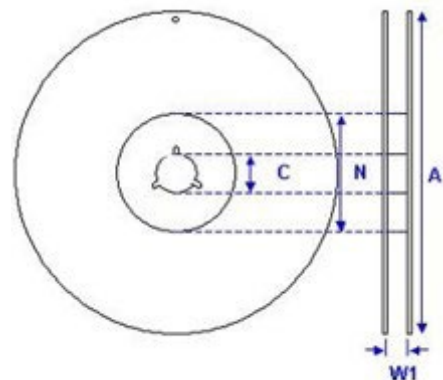
OPTIONAL CODE	SORTING DETAIL
E01	2 cells sorting 0 to +2,5 & +2,5 to +5 (% or pF accoding to value)
E02	4 cells sorting -5 to -2,5 ; -2,5 to 0 ; 0 to +2,5 & +2,5 to 5 (% or pF accoding to value)
E21	2% cells

PACKAGE DIMENSION AND QUANTITY

SIZE	THICKNESS	PAPER TAPE		PLASTIC TAPE	
		7 REEL	13 REEL	7' REEL	13 REEL
0201	0.3 ± 0.05	10 K	50 K		
0402	0.5 ± 0.05	10 K	50 K		
0504	0.6 ± 0.05			4K	15K
	0.9 ± 0.05			4K	15K
0603	0.7 ± 0.07	4K		4K	15K
	0.9 ± 0.07	4K	15K	4K	15K
	0.9 ± 0.07			4K	15K
	1.1 ± 0.07			4K	15K
0805	0.8 ± 0.07	4K	15K	4K	15K
	0.9 ± 0.07			4K	10K
	1.1 ± 0.07			3K	10K
	1.3 ± 0.07			3K	10K
1206	1.1 ± 0.1			3K	10K
	1.4 ± 0.1			3K	8K
	1.8 ± 0.1			2K	8K
1210	1.4 ± 0.1			3K	8K
	1.8 ± 0.1			1K	6K
1808	1.4 ± 0.1			3K	8K
1812	1.6 ± 0.1			2K	8K
	2.1 ± 0.1			1K	6K
	2.8 ± 0.1			1K	6K
2220	1.8 ± 0.1			1K	6K
	3.0 ± 0.1			0.5K	2K
2225	3.0 ± 0.1			0.5K	2K
3033	3.0 ± 0.1			0.5K	2K
3640	3.0 ± 0.1			0.5K	2K
5440	3.9 ± 0.1				0.5K - 1K
HIGH COMPACT 1210				1K	6K
HIGH COMPACT 1812				1K	6K
HIGH COMPACT 2220				0.5K	2K



REEL SIZE	7	7	13
C	13.0 +0.5/-0.2	13.0 +0.5/-0.2	13.0 +0.7/-0.3
W1	8.4 +1.5/-0	12.4 +2.0/-0	8.4 +2.0/-0
A	178.0 ±0.10	178.0 ±0.10	330.0 ±1.0
N	60.0 ±1.0	80.0 ±1.0	100 ±1.0



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PRODUCTION CONTROL

Comparison of the Screening/Testing of the standard and High Reliability SRT-Microcéramique components

	TEST/STRESS	STANDARD SMD	STACKS SRMC RADIALS	HIGH TEMPERATURE	PER ESCC3009	COTS1	COTS2	COTS3	PER MIL-PRF-55681 GROUP A	PER MIL-PRF-123 GROUP A
	CODE			D03	D3009CFM	COTS1	COTS2	COTS3	D55681	D123
	SCOPE	PME MLCC X7R, BX, NPO, N2T, High Q	Encapsulated, Dipped radial and Stacks SRMC	Type 1, Type 2 Chips	SRT PME BME, Radials, Stacks, X7R, BX, N2T, NPO, High Q	Class 1 BME Chips	Class 2 BME Chips	Class 3 BME Chips	PME MLCC X7R, NPO, BX, N2T, High Q	PME MLCC X7R, BX, NPO, N2T, High Q
PROCESS / SCREENING	Burn-In		100% Chips 24H +Stack 48H Tmax 2Un PDA 6.5%	100% 168H Tmax 2Un PDA 6.5%	100% 96H Tmax 2Un PDA 5%	100% 96H Tmax 2Un PDA 5%	100% 96H Tmax 2Un PDA 5% for non AEC-Q200	100% 96H Tmax 2Un PDA 5% for non AEC-Q200	100% 100H Min Tmax 2Un PDA 8%	100% 168H Min 0.1%/1pc last 48H 125°C 2Un PDA 5%
	Capa, DF, IR, VP (25°C)	100%	100%	100%	100%	100%	100%	100%	100%	100%
	IR (125°C)								Sample	Sample
	Voltage Breakdown	10 pcs/lot	10 pcs/lot	10 pcs/lot	10 pcs/lot	10 pcs/lot	10 pcs/lot	10 pcs/lot	10 pcs/lot	10 pcs/lot
	Dimension	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot
	DPA	per lot	per lot	per lot	per lot	per lot	per lot	per lot	per lot	per lot
	Visual	100%	100%	100%	100%	100%	100%	100%	100%	100%
	Resistance to soldering heat	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot
	Solderability	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	6 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot
	Termination thickness	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot	5 pcs/lot
TC	per ceramic lot	per ceramic lot	per ceramic lot	per ceramic lot	per ceramic lot and in LAT	in LAT	in LAT	in LAT	per ceramic lot	per ceramic lot
LAT	On request	On request	On request	On request	Flying Part CFM	Flying part	Flying part	Flying part	On request	On request
LAT SUBGROUP 1	Mounting				20 serialized pcs on PCB					
	Thermal Shock				10 Cycles 30mn/1mn					
	Humidity				For Un<500V 1000h 85/85					
LAT SUBGROUP 2A	Criteria				No visual/electrical default					
	Mounting				40 serialized pcs on PCB	20 serialized pcs on PCB	20 serialized pcs on PCB	20 serialized pcs on PCB		
	Operational Life				1000h ±24 125°C 2Un Un<500V 1.5Un Un=500V 1.3Un 500V<Un<1250V 1Un Un>1250V	1000h ±24 max T° 2Un Un<500V 1.5Un Un=500V 1.3Un 500V<Un<1250V 1Un Un>1250V	1000h ±24 max T° 2Un Un<500V 1.5Un Un=500V 1.3Un 500V<Un<1250V 1Un Un>1250V	1000h ±24 Max T° 2Un Un<500V 1.5Un Un=500V 1.3Un 500V<Un<1250V 1Un Un>1250V		
LAT SUBGROUP 2B	Criteria				No visual/electrical default	No visual/electrical default	No visual/electrical default	No visual/electrical default		
	Mounting				6 serialized pcs on PCB	6 serialized pcs on PCB non AEC-Q200				
	TC				IR at 125°C Cp at -55°C/20°C+125°C	IR at 125°C Cp at -55°C/20°C+125°C				
	Shear Test				5N 10s	5N 10s				
LAT SUBGROUP 3	Criteria				No visual/electrical default	No visual/electrical default				
	Mounting				6 pcs serialized	6 pcs serialized				
	Solderability				Solder bath 235°C 5s included in screening	Solder bath 235°C 5s included in screening				
	Permanence of Marking				ESCC24800 when applicable	ESCC24800 when applicable				
	Criteria				No visual/electrical default	No visual/electrical default				
	Thermal Cycle (optional)									
	Ultrasonic, Xray (optional)									

- All components components can be proposed with SbPb termination (electrolytical I or Dipped H) with 10% min Pb for whisker mitigation with qualified process according to JDEC JESD201A
- Other termination available Silver Palladium F, Solderable Silver Q, Thick Gold G, Flash Gold W, Non Magnetic Copper C, Polymer option P
- ECSS COTS framework is used to propose space ready components Class 1 to 3 based on SRT or customer chosen BME chips either AEC-Q200 (preferred) or non AEC-Q200. Size can start from 0201 and resistors can also be proposed and termination be changed.
- Specific High Reliability programs can be established to fit customer requirement for medical, defense, space, high stress applications.

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RELIABILITY PRINCIPLES OVERVIEW GENERAL PRODUCTION

In order to guarantee highly reliable products to their customers, SRT-Microcéramique follows a strict quality policy which is explained below :

- According to AECQ philosophy, each component belongs to a family, which most restrictive members (four corners) have been fully qualified.
- PME components are produced in our Vendôme facility, with very stable process and equipments, in order to ensure Reliability and reproductibility.
- Reliability is based on batch tests, new product or equipment-specific qualifications and periodic requalifications.
- In addition to those regular tests, our quality departement launches regular accelerated tests to further deepens our reliability datas.
- Tests and qualifications of our standard products are based on AECQ methodology and are qualified according to the following limits.
- In accordance to AECQ methodology, specifics tests and limits can be adapted to fit our clients' needs.
- A whole range of stricter reliability tests can be offered for high Reliability products (burn-in, shocks, pulses...) for medical, space and defense applications.
- Based on our reliability database, FIT datas can be provided if necessary.

PRODUCTION CONTROL

Test conducted on each lot according to AECQ-200 framework

FREQUENCY	TEST/STRESS	REFERENCE	AEC-Q	DETAIL
100%	Capa, DF, IR	CECC-32100-4.6		according to datasheet
100%	Visual	CECC-32100-4.5	AEC-Q200-9	no visual defects
50/lot	DPA		AEC-Q200-5	internal component integrity
5/lot	Dimension	CECC-32100-4.5	AEC-Q200-5	according to datasheet
5/lot	Resistance to soldering heat	CECC-32100-4.10	AEC-Q200-15	
5/lot	Solderability	CECC-32100-4.11	AEC-Q200-18	
10/lot	Voltage Breakdown	CECC-32100-4.6.4		
1/ceramic lot	Temperature coefficient	CECC 32100-Prgph4,7		according to datasheet

QUALIFICATIONS

Each component family has been qualified according to CECC and AECQ tests methodology, which are renewed on a periodic basis.

FREQUENCY	TEST/STRESS	REFERENCE	AEC-Q	DETAIL
Qualif	Electrical Characterization	CECC-32100-4.6 4.7	AEC-Q200-19	measure before test according to datasheet and after test according to post environmental limits
Qualif	Temperature Cycling	JESD22 Method-JA method 104	AEC-Q200-4	1,000 cycles -55°C to +125°C Measurement at 24 ± 2 hours after test conclusion
Qualif	Biased Humidity	MIL-STD-202 Method 103	AEC-Q200-7	1,000 hours 85°C/85%RH. Rated voltage. Measurement at 24 ± 2 hours after test conclusion
Qualif	Operational Life	MIL-STD-202 Method 108 condition D	AEC-Q200-8	1,000 hours at 125°C with applied Voltage : 2xRV RV≤500V, 1.2xRV 500V<RV≤1250V, RV RV>1250V
Qualif	High Temperature Exposure (Storage)	MIL-STD-202 Method 108	AEC-Q200-3	1,000 hours at 150°C with 0V. Measurement at 24 ± 2 hours after test conclusion
Qualif	Terminal Strength	CECC-32100-4.8	AEC-Q200-6	1.8kg 60 seconds
Qualif	Vibration	MIL-STD-202 Method 204	AEC-Q200-14	5g 20min 12cycles 3 orientations 10-2000Hz
Qualif	Board Flex	CEC 32100-4.9	AEC-Q200-21	3mm Type 1, 2mm Type 2, Measurement at 24 ± 2 hours after test conclusion

POST ENVIRONMENTAL STRESS LIMIT

DIELECTRIC	DISSIPATION FACTOR (MAXIMUM)	CAPACITANCE SHIFT	INSULATION RESISTANCE
NPO	≤ 4 10 ⁻³	±2%	10% initial limit
N2T	≤ 6 10 ⁻³	±4%	10% initial limit
X7R	≤ 0.035	±15%	10% initial limit

SPACE LEVEL COMPONENT SCREENED AND QUALIFIED ACCORDING TO ESCC-3009

SRT-Microcéramique can propose a wide range of BME and PME component qualified and tested according to ESCC-3009 standard for space projects. Both for development en evaluation (D32) and flight ready with full lot validation and ESCC standard documentation. Specific qualification programmes can be included to meet final customer requirement.

PRODUCTION CONTROL/SCREENING

Tests conducted on each lot and screening for evaluation components D3009CEM and flying components D3009CFM

FREQUENCY	TEST/STRESS	REFERENCE	DETAIL
Lot	DPA	ESCC-23400	Construction analysis
3/Lot	Dimension/weight	ESCC-20400/20500	Dimension in spec/max weight in spec
100%	Burn-In Non serialized	ESCC-3009	168H, max T°, 2Ur Ur<500V, 1.5Ur Ur=500V, 1.3Ur 500V<Ur≤1250V, 1Ur Ur>1250V (fail<5%)
100%	Room Temperature Electrical Measurements	ESCC-3009	Cp, DF, IR, VP according to datasheet
5/lot	High and Low Temperatures Electrical Measurements	ESCC-3009	0 fail
100%	Visual Inspection	ESCC-20400/20500	

LOT VALIDATION

Lot validation for flying components D3009CFM

FREQUENCY	TEST/STRESS	REFERENCE	DETAIL
20/Lot	PCB Mounting, Rapid Change of Temperature, Steady State Humidity, external visual inspection	ESCC-3009/ IEC 60384-1/IEC 60068-2-14	
20/Lot	PCB Mounting, Life test	ECSS-3009/IEC 60384-1	1000H, max T°, 2Ur Ur<500V, 1.5Ur Ur=500V, 1.3Ur 500V<Ur≤1250V, 1Ur Ur>1250V
6/Lot	PCB Mounting, Temperature Characterisation, Robustness of Terminations	ESCC-3009/ IEC 60068-2-14/IEC 60384-1	
6/Lot	Solderability, Permanence of Marking	ECSS-3009/ IEC 60068-2-58/ ECSS-24800	

SPACE LEVEL COMPONENT SCREENED ACCORDING TO COTS+ ECSS-Q-ST-60-13C-REV1

SRT-Microcéramique can apply the COTS+ qualification framework to any suitable component AEQ-200 or not, to make them fly ready, offering a wide range of possibilities at competitive cost, either in Class 1 (COTS1), Class 2 (COTS2) or Class 3 (COTS3).

EVALUATION/SCREENING/LAT

Class 1 (COTS1), Class 2 (COTS2), Class 3 (COTS3)

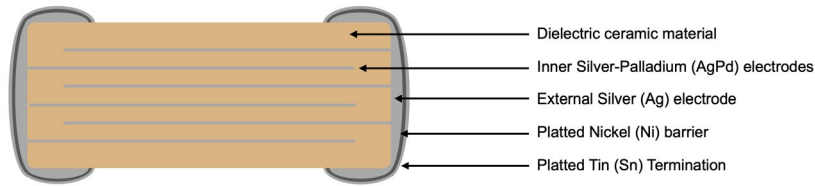
AECQ-200	CLASS 1	CLASS 2	CLASS 3	CATEGORY	TEST TYPE	SAMPLE	PROCEDURE
Yes	X	X	X	Evaluation	Construction Analysis	5	ESCC21001
Yes	X	X	X	Evaluation	Temperature characterization	5	ESCC3009 8.10
Yes	X			Evaluation	Life Test 2000h	40	ESCC3009 8.6 + 8.9
Yes	X			Screening	Complete screening	100%	ESCC3009 chart F3
Yes	X	X	X	LAT	DPA	3	ESCC21001
Yes	X	X		LAT	Life Test 1000h	20	ESCC3009 8.6 + 8.9
No	X	X	X	Evaluation	Construction Analysis	5	ESCC21001
No	X	X	X	Evaluation	Temperature characterization	5	ESCC 3009 8.10
No	X	X		Evaluation	Complete evaluation	72	ESCC 3009 chart F4
No			X	Evaluation	Life Test 1000h	40	ESCC3009 8.6 + 8.9
No	X	X	X	Screening	Complete screening	100%	ESCC3009 chart F3
No	X	X	X	LAT	DPA	3	ESCC21001
No	X			LAT	Complete LAT	52	ESCC 3009 chart F4
No		X	X	LAT	Life Test 1000h	20	ESCC3009 8.6 + 8.9

TINNING

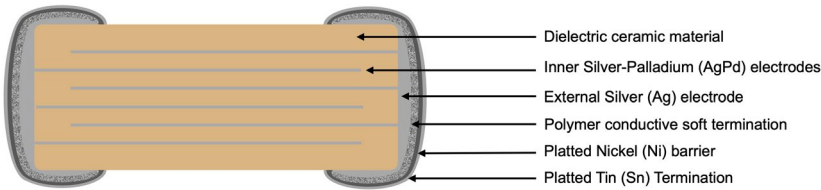
All component for space application can be proposed with dipped SnPb termination (Sn62 Pb36 Ag2) or SAC 305 (Sn96.5 Ag3 Cu0.5) for maximum reliability and whiskers avoidance.

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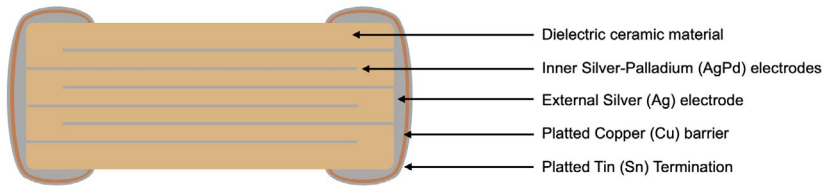
PME (Precious Metal Electrodes)



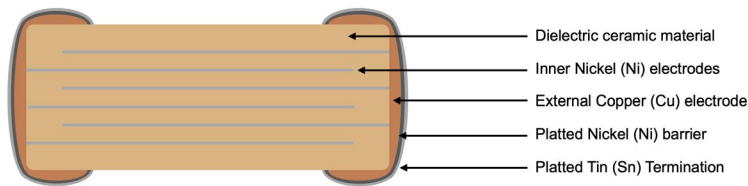
PME (Precious Metal Electrodes) Polymer Soft Termination



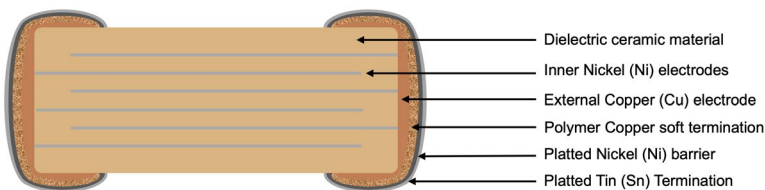
PME (Precious Metal Electrodes) Non Magnetic



BME (Basis Metal Electrodes) code BM



BME (Basis Metal Electrodes) code BM Polymer Soft Termination



REACH Compliance

- SRT-Microcéramique delivers non-chemical articles only.
- These contain no substances which are intended to be released under normal or reasonably foreseeable conditions of use according to Reach article 7(1).

SRT-Microcéramique confirms hereby that our products contain none of the substances which are listed in the present candidate list of the European Chemicals Agency (ECHA), above a concentration of 0.1% by weight of the whole component.

Candidate list of substances (European Chemicals Agency ECHA) :
<http://echa.europa.eu/fr/candidate-list-table>

ROHS COMPLIANCE

SRT-Microcéramique herewith confirms that RoHS-compliant SRT-microcéramique products are conforming to the following EU directives:
EU directive 2015/863/EU EU directive 2011/65/EU EU directive 2003/11/EC

Following restricted materials are not used and do not exceed the legal limits: Lead (Pb, see exemptions),

- Mercury (Hg)
- Cadmium (Cd)
- Chromium (Cr VI)
- Polybrominated biphenyls (PBB) Polybrominated diphenyl ethers (PBDE) Bis(2-Ethylhexyl) phthalate (DEHP) Benzyl butyl phthalate (BBP)
- Dibutyl phthalate (DBP) Diisobutyl phthalate (DIBP)

Exemptions: The following exemptions according to the RoHS annexe are applicable:

Identity 7(a) :

- Lead in high melting temperature type solders (i.e lead-based alloys containing 85% by weight or more lead).

Identity 7(c)-I :

- Electrical and electronic components containing lead in a glass or ceramic other than dielectric ceramic capacitors, e.g. piezoelectronic devices, or in a glass or ceramic matrix compound.

The components are suitable for a lead-free process according to EN 60068-2-58 and in accordance with the IPC/JEDEC standard J-Std-020D. The lead free process has been tested using solder alloy Sn96.5Ag3Cu0.5

Export controls and dual-use regulations

Some SRT-Microcéramique components fall under 'dual-use' items under international export controls definition - those that can be used for civil or military purposes which meet certain specified technical standards.

The defining criteria for a dual use component is one with a voltage rating of >750Vdc and a capacitance value of >250nF when measured at 750Vdc and a series inductance <10nH. Components defined as dual-use under the above criteria may require a licence for export across international borders. Please contact us for further information on specific part numbers.

ISO9001:2015

In their design, research and development as well as the manufacturing of MLCC capacitors, customer service and distribution SRT-Microcéramique uses and maintains a Management System audited and certified in accordance to : **ISO9001:2015**

You may contact us for any inquiry regarding the regulations and compliance listed above.